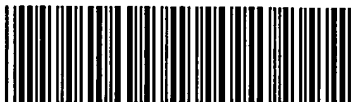


Search Notes

Application/Control No.

10/611,931

Examiner

Chris C. Chu

Applicant(s)/Patent under
Reexamination

ANDRICACOS ET AL.

Art Unit

2815

SEARCHED

Class	Subclass	Date	Examiner
438	652, 654, 653 & 687	8/18/2005	C.C.
257	758	8/18/2005	C.C.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
as same	as above	8/18/2005	C.C.

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched in US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; and IBM_TDB;	8/18/2005	C.C.
Consulted with David Graybill	10/13/2004	C.C.